

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re the Application of:	TI-37087
Rishi Bhooshan, et al.	Art Unit: 2825
Serial No: 10/710,693	Examiner: Phallaka Kik
Filed: July 29, 2004	Conf. No.: 4692
For: Electro-Migration (EM) and Voltage (IR) Drop Analysis of Integrated Circuit (IC) Designs	

**AMENDMENT PURSUANT TO 37 CFR 1.116**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Applicant has received the Office Action mailed June 14, 2007, which rejected Claims 1-12 and 25-36.